TI0101--D3334, JUNE 1989--REVISED MARCH 1990

- Fiow-Through Architecture to Optimize PCB Layout
- Center-Pin V<sub>CC</sub> and GND Configurations to Minimize High-Speed Switching Noise
- EPIC™ (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DiPs

### description

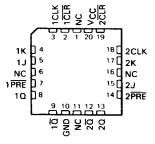
These devices contain two independent J-K negative-edge-triggered flip-flops. A low level at the Preset or Clear inputs sets or resets the outputs regardless of the levels of the other inputs. When Preset and Clear are inactive (high), data at the J and K inputs meeting the setup time requirements are transferred to the outputs on the negative-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the fall time of the clock pulse. Following the hold-time interval, data at the J and K inputs may be changed without affecting the levels at the outputs. These versatile flip-flops can perform as toggle flip-flops by tying J and K high.

The 54AC11112 is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to 125°C. The 74AC11112 is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}.$ 

#### 54AC11112 ... J PACKAGE 74AC11112 ... D OR N PACKAGE (TOP VIEW)

1PRE	ī	U 16	] 1J
1 Q 🛚	2	15	] 1K
10 🗌	3	14	] 1CLK
GND [	4	13	1CLR
20 🗌	5	12	□vcc
20 🗌	6	11	2CLR
2PRE	7	10	2CLK
2J 🗌	8	9	] 2K

#### 54AC11112 ... FK PACKAGE (TOP VIEW)



NC-No internal connection

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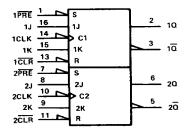
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#### **FUNCTION TABLE**

	INF	PUTS	OUTI	PUTS			
PRE	CLR	CLK	J	K	Q	Q	
L	Н	Х	Х	Х	Н	L	
н	L	×	Х	Х	L	н	
L	L	X	X	X	H <sup>†</sup>	H <sup>†</sup>	
Н	н	1	L	L	Q <sub>0</sub>	$\overline{\Omega}_0$	
н	н	1	Н	L	н	L	
н	н	1	L	Н	Ł	Н	
н	н	1	н	Н	TOGGLE		
н	н	н	×	×	$Q_0$	$\overline{Q}_0$	

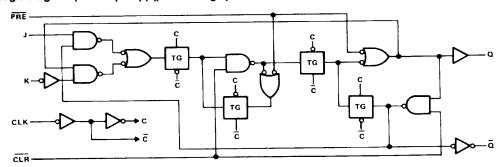
<sup>&</sup>lt;sup>†</sup> This configuration is nonstable; that is, it will not persist when either Preset or Clear returns to the inactive (high) level.

### logic symbol‡



<sup>&</sup>lt;sup>‡</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, J, and N packages.

#### logic diagram (each flip-flop) (positive logic)





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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, VCC			-0.5	V to	7 V
Input voltage range, V <sub>I</sub> (see Note 1)	-0.5	V to	Vcc	+ 0.	.5 V
Output voltage range, VO (see Note 1)	-0.5	V to	VCC	+ 0.	.5 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ )				$\pm 20$	mΑ
Output clamp current, IOK (VO < 0 or VO > VCC)				$\pm 50$	mΑ
Continuous output current, IO (VO = 0 to VCC)				$\pm 50$	mΑ
Continuous current through VCC or GND pins			±	100	mΑ
Storage temperature range			65°C	to 15	0°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### recommended operating conditions

	100		54	54AC11112 74AC11112			2	UNIT	
			MIN	NOM	MAX	MIN	NOM	MAX	0.41.1
VCC	Supply voltage		3	5	5.5	3	5	5.5	V
		VCC = 3 V	2.1			2.1			
VιΗ	High-level input voltage	$V_{CC} = 4.5 V$	3.15			3.15			٧
		$V_{CC} = 5.5 V$	3.85			3.85			
		ACC = 3 A			0.9			0.9	
VIL	Low-level input voltage	V <sub>CC</sub> = 4.5 V			1.35			1.35	<b>V</b>
		V <sub>CC</sub> = 5.5 V		***	1.65			1.65	
VI	Input voltage	-	0		Vcc	0		Vcc	V
٧o	Output voltage		0		Vcc	0		Vcc	٧
		ACC = 3 A			-4			-4	
ЮН	High-level output current	$V_{CC} = 4.5 V$			- 24			-24	mΑ
		V <sub>CC</sub> = 5.5 V			-24			-24	
		ACC = 3 A			12			12	
IOL	Low-level output current	V <sub>CC</sub> = 4.5 V			24			24	mA
		$V_{CC} = 5.5 V$			24			24	
Δt/Δν	Input transition rise or fall rate	· · · · · · · · · · · · · · · · · · ·	0		10	0		10	ns/V
TA	Operating free-air temperature		- 55		125	-40		85	°C

PRODUCT PREVIEW information concerns products in the formative or design phase of development. Characteristic data and other specifications are design goals. Texas instruments reserves the right to change or discontinue these products without notice.



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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TER TEST CONDITIONS		T,	= 25°C		54AC	11112	74AC11112		LINIT	
FARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
	I <sub>OH</sub> = -50 μA	3 V	2.9			2.9		2.9			
		4.5 V	4.4			4.4		4.4			
		5.5 V	5.4			5.4		5.4			
Voн	IOH = -4 mA	3 V	2.58			2.4		2.48		v	
, von	IOH = -24 mA	4.5 V	3.94			3.7		3.8		•	
	1011	5.5 V	4.94			4.7	jih.	4.8			
	$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V				3.85	4.				
	IOH = -75 mA†	5.5 V					6	3.85			
-		3 V			0.1		0.1		0.1		
	IOL = 50 μA	4.5 V	1		0.1		0.1		0.1		
		5.5 V			0.1	***	0.1		0.1		
VOL	IOL = 12 mA	3 V			0.36	177	0.5		0.44	v	
100	IOL = 24 mA	4.5 V			0.36		0.5		0.44	V	
	10L 24111/1	5.5 V			0.36		0.5		0.44		
	I <sub>OL</sub> = 50 mA <sup>†</sup>	5.5 V					1.65				
	IOL = 75 mA†	5.5 V							1.65		
l <sub>l</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	5.5 V			± 0.1		±1		± 1	μА	
Icc	V <sub>I</sub> = V <sub>CC</sub> or GND, I <sub>O</sub> = 0	5.5 V	1		4		80		40	μA	
Ci	V <sub>C</sub> = V <sub>CC</sub> or GND	5 V		3.5						pF	

<sup>†</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

# timing requirements over recommended operating free-air temperature range, $V_{CC}=3.3~V~\pm0.3~V$ (unless otherwise noted) (see Figure 1)

	PARAMETER	TA =	25°C	54AC	54AC11112		74AC11112		
				MAX	MIN	MAX	MIN	MAX	UNIT
fclock	Clock frequency		0	100	0	100	0	100	MHz
tw Pulse durat	Pulse duration	PRE or CLR low	5		5	3 10	5	5	
	. 5.55 52.45.	CLK low or high	5		5		5		ns
t <sub>SU</sub>	Setup time, data before CLK 1	Data high or low	5		5		5	5	
·su	Cotap time, data before CER \$	PRE or CLR inactive	2.5		2.5		2.5		ns
th	Hold time, data after CLK ↓		0.5		0.5		0.5		ns





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# timing requirements over recommended operating free-air temperature range, $V_{CC}=5~V~\pm0.5~V$ (unless otherwise noted) (see Figure 1)

	PARAMETER	TA =	25°C	54AC	54AC11112		74AC11112		
	PANAMETER		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
fclock	Clock frequency		0	125	0	125	0	125	MHz
tw	Pulse duration	PRE or CLR low	4		4	1.4	4		ns
'w		CLK low or high	4		4		4		
tsu	Setup time, data before CLK 1	Data high or low	3.5		3.5		3.5		ns
'Su	Solup limo, data poloto SEN \$	PRE or CLR inactive	2	· ·	2		2		1.0
th	Hold time, data after CLK ↓		1		1		1		ns

# switching characteristics over recommended operating free-air temperature range, $V_{CC}=3.3~V~\pm~0.3~V$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	FROM TO (INPUT) (OUTPUT)	T	T <sub>A</sub> = 25°C			54AC11112		74AC11112	
PARAMETER	(INPUT)		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
fmax			100	150		100		100		MHz
t <sub>PLH</sub>	PRE or CLR	Q or $\overline{Q}$	1.5	4.9	6.7	1.5	7.6	1.5	7.3	ns
tPHL.	THE OF OLIN	Q 01 Q	1.5	7	9.2	1.5	10.3	1.5	9.9	
tpLH .	CLK	Q or Q	1.5	5.4	7.1	1.5	7.9	1.5	7.6	ns
t <sub>PHL</sub>	]	4014	1.5	6	7.9	1.5	9	1.5	8.5	110

# switching characteristics over recommended operating free-air temperature range, $V_{CC}=5~V~\pm~0.5~V$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то		TO T <sub>A</sub> = 25°C		54AC	11112	74AC11112		UNIT
	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
fmax			125	175		125		125		MHz
<sup>‡</sup> PLH	PRE or CLR	QorŌ	1.5	3.3	5.1	1.5	5.6	1.5	5.4	ns
†PHL			1.5	4.6	6.7	1.5	7.7	1.5	7.3	
t <sub>PLH</sub>	CLK	QorQ	1.5	3.4	5.1	1.5	5.8	1.5	5.6	ns
†PHL			1.5	4.2	6.3	1.5	7.4	1.5	7	,,,,

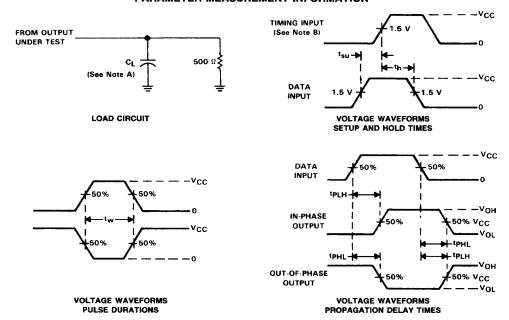
## operating characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C	Device discipation of the second of the seco	C <sub>L</sub> = 50 pF, f = 1 MHz	37	pF



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### PARAMETER MEASUREMENT INFORMATION



NOTES: A. CL includes probe and jig capacitance.

B. Input pulses are supplied by generators having the following characteristics: PRH  $\leq$  10 MHz, Z<sub>0</sub> = 50  $\Omega$ , t<sub>f</sub> = 3 ns, t<sub>f</sub> = 3 ns.

C. The outputs are measured one at a time with one input transition per measurement.

FIGURE 1. LOAD CIRCUIT AND VOLTAGE WAVEFORMS

